


<b>FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</b>	<b>ATTY DOCKET NO.</b> DN2001205	<b>SERIAL NO.</b>
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use several sheets if necessary)	<b>APPLICANT (S)</b> Rene Jean Zimmer, et al	
	<b>FILING DATE</b>	<b>GROUP</b>
		

### U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date if Appropriate	
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Examiner Initial	Document Number	Date	Country	Class	Sub-Class	Translation YES NO	
<i>jm</i>	JP57107823A	JUL 05, 1982	JAPAN	<del>B29D</del>	—		
<i>jm</i>	JP5208454A2	AUG 20, 1993	JAPAN	<del>B29D</del>	—		
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Examiner Initial		
<i>jm</i>		Patent Abstracts of Japan, Application No. 55183769
EXAMINER	Maki	DATE CONSIDERED: 11-14-03

Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.